Search Notes



Application/Control No.	

Applicant(s)/Patent under Reexamination

10/007,364 Examiner

Julian W. Woo

KAPLAN ET AL.

3731

SEARCHED					
Subclass	Date	Examiner			
of 3/23/06	8-16-06	gnrur			
175.1	8-16-06	gmm			
191,198	8-17-06	gmm			
207	817-06	gmm			
-					
,					
	Subclass of f 3/23/06 175.1 191,198	Subclass Date of 3/23/06 8-16-06 175.1 8-16-06 191,198 8-17-06			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
606	139,142	8-17-06	gmm		
606	205	8-17-06	JMM		
gee at interfer scarch	td EAST ence	8-17-06	g mm		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST (see attd) EAST (see attd)	8-16-06 8-17-06	g mm	
•			
· ·			